

# OptiMOS™-T2 Power-Transistor

# AEC® ® Qualified



#### **Features**

- N-channel Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green product (RoHS compliant)
- Ultra low Rds(on)
- 100% Avalanche tested

Туре	Package	Marking
IPB240N04S4-R9	PG-TO263-7-3	4N04R9

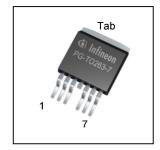
# **Maximum ratings,** at $T_j$ =25 °C, unless otherwise specified

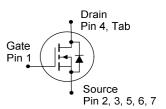
Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	ID	$T_{\rm C}$ =25°C, $V_{\rm GS}$ =10 $V^{1)}$	240	А
		T <sub>C</sub> =100 °C, V <sub>GS</sub> =10 V <sup>2)</sup>	240	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	T <sub>C</sub> =25 °C	960	
Avalanche energy, single pulse <sup>2)</sup>	E <sub>AS</sub>	I <sub>D</sub> =120 A	750	mJ
Avalanche current, single pulse	IAS	-	190	А
Gate source voltage	$V_{GS}$	-	±20	V
Power dissipation	$P_{\text{tot}}$	T <sub>C</sub> =25 °C	300	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 +175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	

## **Product Summary**

V <sub>DS</sub>	40	V
R <sub>DS(on)</sub>	0.87	mΩ
I <sub>D</sub>	240	Α

#### PG-TO263-7-3







Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics <sup>2)</sup>						
Thermal resistance, junction - case	$R_{thJC}$	-	-	-	0.5	K/W
SMD version, device on PCB	$R_{thJA}$	minimal footprint	-	-	62	
		6 cm <sup>2</sup> cooling area <sup>3)</sup>	-	-	40	

# **Electrical characteristics,** at $T_j$ =25 °C, unless otherwise specified

#### **Static characteristics**

Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	$V_{\rm GS}$ =0 V, $I_{\rm D}$ = 1 mA	40	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 230 \ \mu {\rm A}$	2.0	3.0	4.0	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> =40 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C	-	0.1	1	μΑ
		$V_{DS}$ =18 V, $V_{GS}$ =0 V, $T_{j}$ =85 °C <sup>2)</sup>	-	20	240	
Gate-source leakage current	$I_{\mathrm{GSS}}$	$V_{\rm GS}$ =20 V, $V_{\rm DS}$ =0 V	-	-	100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10 V, I <sub>D</sub> =100 A	-	-	0.87	mΩ



Parameter	Symbol Conditions	Values			Unit	
			min.	typ.	max.	
Dynamic characteristics <sup>2)</sup>						
Input capacitance	C <sub>iss</sub>		-	17700	23000	pF
Output capacitance	Coss	$V_{GS}$ =0 V, $V_{DS}$ =25 V, $f$ =1 MHz	-	3850	5000	1
Reverse transfer capacitance	C <sub>rss</sub>		-	150	345	
Turn-on delay time	t <sub>d(on)</sub>		-	55	-	ns
Rise time	t <sub>r</sub>	$V_{\rm DD}$ =20 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =240 A,	-	28	-	_
Turn-off delay time	$t_{d(off)}$	$R_{G,ext}$ =3.5 $\Omega$	-	64	-	
Fall time	$t_{f}$		-	59	-	
Gate Charge Characteristics <sup>2)</sup> Gate to source charge	Q <sub>gs</sub>		-	90	117	nC
Gate to drain charge	Q <sub>gd</sub>	$V_{DD}$ =32 V, $I_{D}$ =240 A, $V_{GS}$ =0 to 10 V	-	32	65	
Gate charge total	Qg		-	220	290	
Gate plateau voltage	V <sub>plateau</sub>		-	5.4	-	V
Reverse Diode	•					
Diode continous forward current <sup>2)</sup>	Is	. T <sub>C</sub> =25 °C	-	-	240	Α
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	1 C=20 C	-	-	960	7
Diode forward voltage	$V_{\mathrm{SD}}$	V <sub>GS</sub> =0 V, I <sub>F</sub> =100 A, T <sub>j</sub> =25 °C	-	0.9	1.3	V
Reverse recovery time <sup>2)</sup>	t <sub>rr</sub>	V <sub>R</sub> =20 V, I <sub>F</sub> =50A,	-	85	-	ns
Reverse recovery charge <sup>2)</sup>	Q <sub>rr</sub>	$di_F/dt=100 A/\mu s$	_	130	_	nC

 $<sup>^{1)}</sup>$  Current is limited by bondwire; with an  $R_{thJC}$  = 0.5 K/W the chip is able to carry 451A at 25°C.

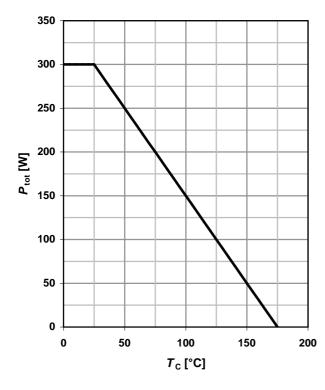
<sup>&</sup>lt;sup>2)</sup> Defined by design. Not subject to production test.

 $<sup>^{3)}</sup>$  Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^{2}$  (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical in still air.



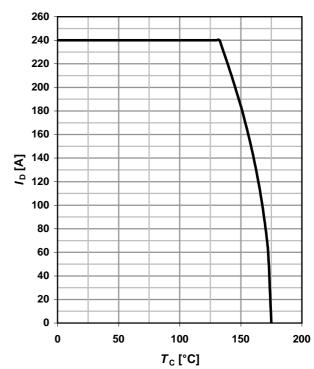
## 1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$$



#### 2 Drain current

$$I_D = f(T_C); V_{GS} \ge 6 \text{ V}$$



## 3 Safe operating area

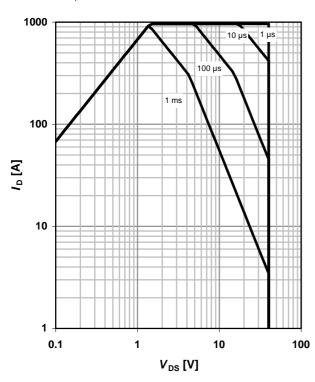
$$I_D = f(V_{DS}); T_C = 25 \text{ °C}; D = 0$$

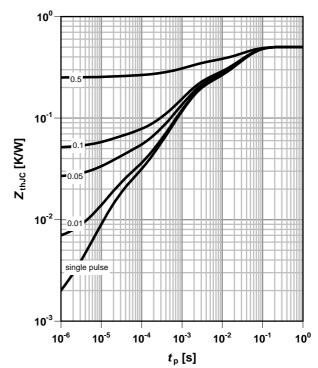
parameter:  $t_p$ 

## 4 Max. transient thermal impedance

$$Z_{\rm thJC} = f(t_{\rm p})$$

parameter:  $D=t_p/T$ 



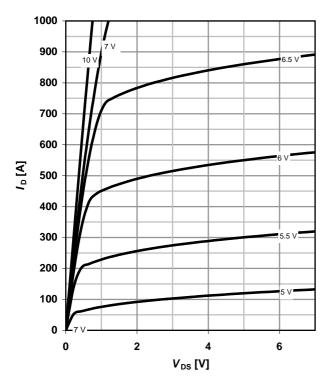




## 5 Typ. output characteristics

 $I_{\rm D} = f(V_{\rm DS}); T_{\rm j} = 25 \,{}^{\circ}{\rm C}$ 

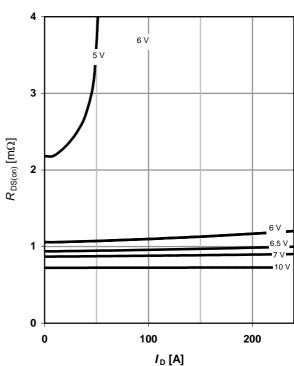
parameter: V<sub>GS</sub>



## 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = (I_D); T_j = 25 \text{ °C}$ 

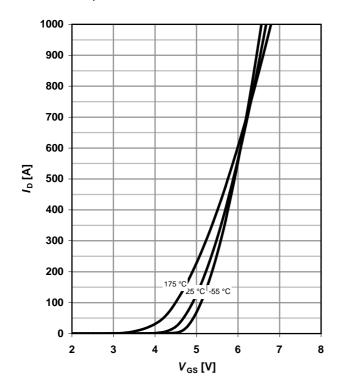
parameter:  $V_{\rm GS}$ 



## 7 Typ. transfer characteristics

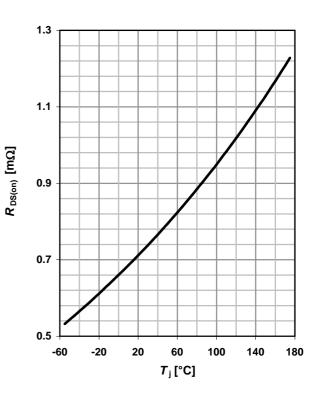
 $I_{\rm D} = f(V_{\rm GS}); V_{\rm DS} = 6V$ 

parameter: T<sub>i</sub>



## 8 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(T_j); I_D = 100 \text{ A}; V_{GS} = 10 \text{ V}$ 





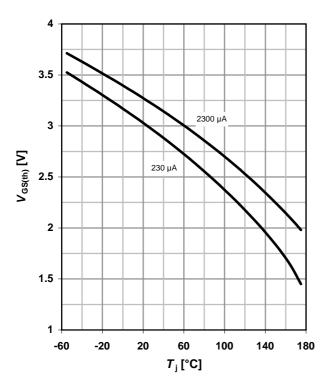
## 9 Typ. gate threshold voltage

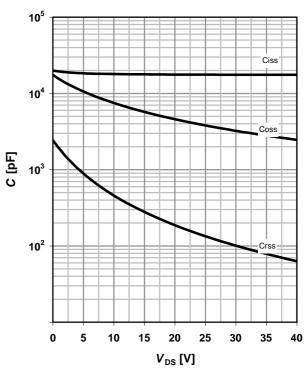
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$ 

parameter:  $I_D$ 

## 10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$ 





## 11 Typical forward diode characteristicis

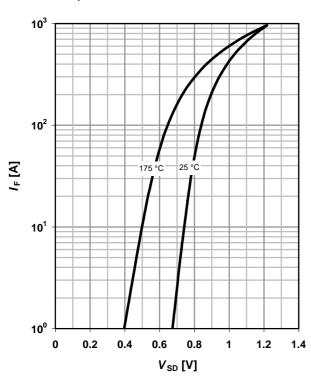
 $IF = f(V_{SD})$ 

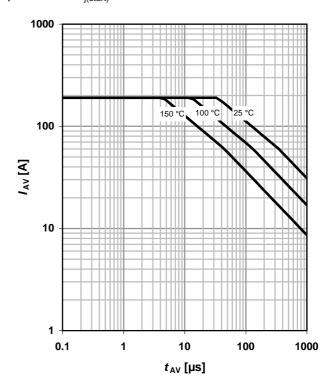
parameter: T<sub>i</sub>

## 12 Typ. avalanche characteristics

 $I_{AS} = f(t_{AV})$ 

parameter: T<sub>j(start)</sub>







## 13 Typical avalanche energy

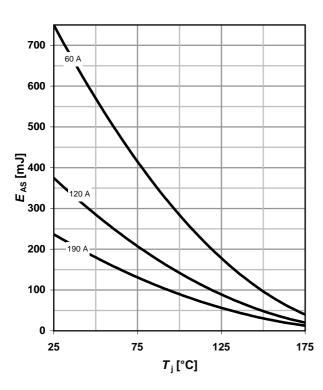
 $E_{AS} = f(T_i)$ 

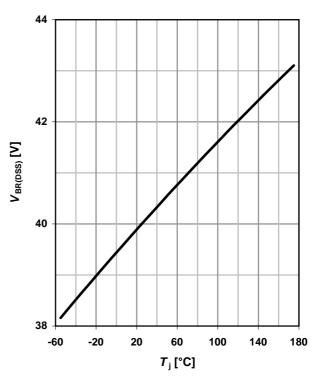
parameter:  $I_D$ 

## 14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$

16 Gate charge waveforms

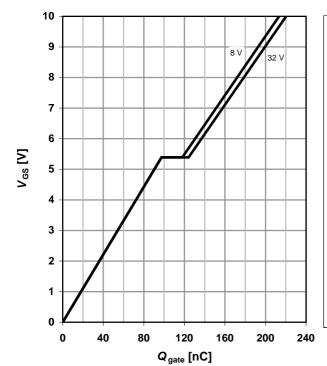


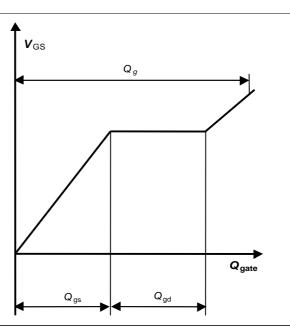


# 15 Typ. gate charge

 $V_{GS} = f(Q_{gate}); I_D = 240 \text{ A pulsed}$ 

parameter: V<sub>DD</sub>







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# Revision History

Version	Date	Changes
Revision 1.0	16.08.2013	Final Data Sheet
Revision 1.1	07.04.2014	Changed Hot Temperature I <sub>DSS</sub> Changed Dynamic Values Changed E <sub>AS</sub>